

- 4.1** Calculate the intrinsic carrier concentration, n_i , at $T = 200, 400$, and 600 K for
 (a) silicon, (b) germanium, and (c) gallium arsenide.

$$n_i^2 = N_C N_V \exp \left[-\frac{(E_C - E_F)}{kT} \right]$$

a.)

$$T = 200\text{K}$$

$$n_i^2 = (2.8 \times 10^{19}) (1.04 \times 10^{14}) \left(\frac{200}{300} \right)^{3/2} \left(\frac{200}{300} \right)^{3/2} \exp \left(\frac{-1.12}{0.0251 \left(\frac{200}{300} \right)} \right)$$

$$n_i^2 = 5.83 \times 10^9$$

$$n_i = 7.6 \times 10^{14} / \text{cm}^3$$

$$T = 400\text{K}$$

$$n_i^2 = (2.8 \times 10^{19}) (1.04 \times 10^{14}) \left(\frac{400}{300} \right)^{3/2} \left(\frac{400}{300} \right)^{3/2} \exp \left(\frac{-1.12}{0.0251 \left(\frac{400}{300} \right)} \right)$$

$$n_i^2 = 5.67 \times 10^{24}$$

$$n_i = 2.38 \times 10^{12} / \text{cm}^3$$

$$T = 600\text{K}$$

$$n_i^2 = (2.8 \times 10^{19}) (1.04 \times 10^{14}) \left(\frac{600}{300} \right)^{3/2} \left(\frac{600}{300} \right)^{3/2} \exp \left(\frac{-1.12}{0.0251 \left(\frac{600}{300} \right)} \right)$$

$$n_i^2 = 9.49 \times 10^{29}$$

$$n_i = 9.74 \times 10^{14} / \text{cm}^3$$

b.)

$$T = 200\text{K}$$

$$n_i^2 = (6 \times 10^{18}) (1.04 \times 10^{14}) \left(\frac{200}{300} \right)^{3/2} \left(\frac{200}{300} \right)^{3/2} \exp \left(\frac{-0.66}{0.0251 \left(\frac{200}{300} \right)} \right)$$

$$n_i^2 = 4.64 \times 10^{20}$$

$$n_i = 2.16 \times 10^{10} / \text{cm}^3$$

$$T = 400\text{K}$$

$$n_i^2 = (6 \times 10^{18}) (1.04 \times 10^{14}) \left(\frac{400}{300} \right)^{3/2} \left(\frac{400}{300} \right)^{3/2} \exp \left(\frac{-0.66}{0.0251 \left(\frac{400}{300} \right)} \right)$$

$$n_i^2 = 7.41 \times 10^{29}$$

$$n_i = 8.6 \times 10^{14} / \text{cm}^3$$

$$T = 600\text{K}$$

$$n_i^2 = (6 \times 10^{18}) (1.04 \times 10^{14}) \left(\frac{600}{300} \right)^{3/2} \left(\frac{600}{300} \right)^{3/2} \exp \left(\frac{-0.66}{0.0251 \left(\frac{600}{300} \right)} \right)$$

$$n_i^2 = 1.46 \times 10^{30}$$

$$n_i = 3.86 \times 10^{16} / \text{cm}^3$$

c.)

$$T = 200 \text{ K}$$

$$n_i^2 = (4.7 \times 10^{17})(1.04 \times 10^{14}) \left(\frac{200}{300}\right)^{3/2} \left(\frac{200}{300}\right)^{3/2} \exp\left(\frac{-1.42}{0.0259\left(\frac{200}{300}\right)}\right)$$

$$n_i^2 = 1.87$$

$$n_i = 1.37 / \text{cm}^3$$

$$T = 400 \text{ K}$$

$$n_i^2 = (4.7 \times 10^{17})(1.04 \times 10^{14}) \left(\frac{400}{300}\right)^{3/2} \left(\frac{400}{300}\right)^{3/2} \exp\left(\frac{-1.42}{0.0259\left(\frac{400}{300}\right)}\right)$$

$$n_i^2 = 1.08 \times 10^{19}$$

$$n_i = 3.29 \times 10^9 / \text{cm}^3$$

$$T = 600 \text{ K}$$

$$n_i^2 = (4.7 \times 10^{17})(1.04 \times 10^{14}) \left(\frac{600}{300}\right)^{3/2} \left(\frac{600}{300}\right)^{3/2} \exp\left(\frac{-1.42}{0.0259\left(\frac{600}{300}\right)}\right)$$

$$n_i^2 = 3.27 \times 10^{25}$$

$$n_i = 5.72 \times 10^{12} / \text{cm}^3$$

4.12

(a) The carrier effective masses in a semiconductor are $m_n^* = 1.21 m_0$ and $m_p^* = 0.70 m_0$.

Determine the position of the intrinsic Fermi level with respect to the center of the bandgap at $T = 300 \text{ K}$. (b) Repeat part (a) if $m_n^* = 0.080 m_0$ and $m_p^* = 0.75 m_0$.

$$\text{a.) } E_{F_i} - \frac{E_g}{2} = \frac{3}{4} kT \left[\ln\left(\frac{m_p^*}{m_n^*}\right) \right]$$

$$= \frac{3}{4} (0.0259) \left[\ln\left(\frac{0.70}{1.21}\right) \right]$$

$$= -0.0106 \text{ eV}$$

$$= -10.6 \text{ meV}$$

$$\text{b.) } E_F = \frac{3}{4} kT \left[\ln\left(\frac{m_p^*}{m_n^*}\right) \right]$$

$$= \frac{3}{4} (0.0259) \left[\ln\left(\frac{0.75}{0.080}\right) \right]$$

$$= 0.043 \text{ eV}$$

$$= \boxed{43 \text{ meV}}$$

- 4.17** Silicon at $T = 300 \text{ K}$ is doped with arsenic atoms such that the concentration of electrons is $n_0 = 7 \times 10^{15} \text{ cm}^{-3}$. (a) Find $E_c - E_F$. (b) Determine $E_F - E_v$. (c) Calculate p_0 . (d) Which carrier is the minority carrier? (e) Find $E_F - E_{F_i}$.

$$\begin{aligned} \text{a.) } E_c - E_F &= kT \left[\ln \left(\frac{N_c}{n_0} \right) \right] \\ &= (0.0259) \left[\ln \left(\frac{2.8 \times 10^{19}}{7 \times 10^{15}} \right) \right] \\ &= \boxed{0.215 \text{ eV}} \end{aligned}$$

$$\begin{aligned} \text{b.) } E_F - E_v &= E_g - [E_c - E_F] \\ &= 1.12 - 0.2148 \\ &= \boxed{0.905 \text{ eV}} \end{aligned}$$

$$\begin{aligned} \text{c.) } n_0 p_0 &= N_c N_v \exp \left(-\frac{E_g}{kT} \right) \\ &\quad N_c N_v \exp \left(-\frac{E_g}{kT} \right) \\ p_0 &= \frac{n_0}{N_c N_v} \\ p_0 &= \frac{(2.8 \times 10^{19})(1.04 \times 10^{19}) \exp \left(\frac{-1.12}{0.0259} \right)}{7 \times 10^{15}} \\ p_0 &= \boxed{6.9 \times 10^3 / \text{cm.}^3} \end{aligned}$$

d.) $n_0 > p_0$ @ Thermal Equilibrium
 There is a higher concentration of electrons than holes, making holes the minority carrier.

$$\begin{aligned} \text{e.) } n_0 &= n_i \exp \left[\frac{E_F - E_{F_i}}{kT} \right] \\ E_F - E_{F_i} &= kT \left[\ln \left(\frac{n_0}{n_i} \right) \right] \\ &= 0.0259 \left[\ln \left(\frac{7 \times 10^{15}}{1.5 \times 10^{10}} \right) \right] \\ &= \boxed{0.338 \text{ eV}} \end{aligned}$$

- 4.20** (a) If $E_c - E_F = 0.28 \text{ eV}$ in gallium arsenide at $T = 375 \text{ K}$, calculate the values of n_0 and p_0 . (b) Assuming the value of n_0 in part (a) remains constant, determine $E_c - E_F$ and p_0 at $T = 300 \text{ K}$.

$$n_o = N_c \exp \left[-\frac{(E_c - E_F)}{kT} \right]$$

$$N_c = 2 \left[\frac{2\pi m^* kT}{h^2} \right]^{3/2} \quad \text{where } N_c \propto T^{3/2}$$

For N_c @ 375 K:

$$\frac{N_{c1}}{N_{c2}} = \left(\frac{T_1}{T_2} \right)^{3/2}$$

$$N_{c1} = N_{c2} \left(\frac{T_1}{T_2} \right)^{3/2}$$

$$= 4.7 \times 10^{17} \left(\frac{375}{300} \right)^{3/2} = 6.57 \times 10^{17} / \text{cm}^3$$

a.)

$$n_o = 6.57 \times 10^{17} \exp \left(\frac{-0.28}{0.032075} \right) = 11.52 \times 10^{13} / \text{cm}^3$$

$$N_{V1} = N_{V2} \left(\frac{T_1}{T_2} \right)^{3/2} = 7 \times 10^{18} \left(\frac{375}{300} \right)^{3/2}$$

$$N_{V1} = 9.78 \times 10^{18} / \text{cm}^3$$

$$P_o = 9.78 \times 10^{18} \exp \left[\frac{-(1.42 - 0.28)}{0.032075} \right]$$

$$P_o = 4.9 \times 10^3 / \text{cm}^3$$

b.)

$$n_o = N_c \exp \left[-\frac{(E_c - E_F)}{kT} \right]$$

$$E_c - E_F = kT \left[\ln \left(\frac{N_c}{n_o} \right) \right] = 0.0259 \left[\ln \left(\frac{4.7 \times 10^{17}}{11.52 \times 10^{13}} \right) \right]$$

$$E_c - E_F = 0.22 \text{ eV}$$

$$E_F - V_V = E_g - (E_c - E_F) = 1.42 - 0.22 = 1.2$$

$$P_0 = 7 \times 10^{18} \exp\left[\frac{-1.2}{0.0259}\right]$$

$$P_0 = 0.044 \text{ cm}^{-3}$$

- 4.24** Silicon at $T = 300 \text{ K}$ is doped with boron atoms such that the concentration of holes is $p_0 = 5 \times 10^{15} \text{ cm}^{-3}$. (a) Find $E_F - E_v$. (b) Determine $E_c - E_F$. (c) Determine n_0 . (d) Which carrier is the majority carrier? (e) Determine $E_{F_i} - E_F$.

$$N_c = 2.8 \times 10^{19} \text{ cm}^{-3} \quad N_v = 1.04 \times 10^{19} \text{ cm}^{-3} \quad E_g = 1.12 \text{ eV}$$

a.)

$$P_0 = N_v \exp\left[\frac{-(E_F - E_v)}{kT}\right]$$

$$5 \times 10^{15} = 1.04 \times 10^{19} \exp\left[\frac{-(E_F - E_v)}{0.0259}\right]$$

$$E_F - E_v = 0.198 \text{ eV}$$

b.) $(E_c - E_F) = E_g - (E_F - E_v)$

$$E_c - E_F = 1.12 - 0.198$$

$$E_c - E_F = 0.922 \text{ eV}$$

c.)

$$n_0 = N_c \exp\left[\frac{-(E_c - E_F)}{kT}\right] = 2.8 \times 10^{19} \exp\left[\frac{-0.922}{0.0259}\right]$$

$$n_0 = 9.66 \times 10^{13} \text{ cm}^{-3}$$

d.) $P_0 > n_0$ Positive charge carrier (holes) are in the majority. Thus, it is P-type.

e.) $E_{F_i} - E_F = kT \ln\left(\frac{P_0}{n_0}\right)$

$$E_{F_i} - E_F = (0.0259) \left[\ln\left(\frac{5 \times 10^{15}}{9.66 \times 10^{13}}\right) \right]$$

$$E_{F_i} - E_F = 0.3293 \text{ eV}$$

- 4.39 A silicon semiconductor material at $T = 300 \text{ K}$ is doped with arsenic atoms to a concentration of $2 \times 10^{15} \text{ cm}^{-3}$ and with boron atoms to a concentration of $1.2 \times 10^{15} \text{ cm}^{-3}$. (a) Is the material n type or p type? (b) Determine n_0 and p_0 . (c) Additional boron atoms are to be added such that the hole concentration is $4 \times 10^{15} \text{ cm}^{-3}$. What concentration of boron atoms must be added and what is the new value of n_0 ?

a.) $2 \times 10^{15} / \text{cm}^3$ donors > $1.2 \times 10^{15} / \text{cm}^3$ acceptors

\therefore The material is n-type

$$\begin{aligned} b.) \quad n_0 &= \frac{(N_d - N_a)}{2} + \sqrt{\left(\frac{N_d - N_a}{2}\right)^2 + n_i^2} \\ n_0 &= \frac{((2 \times 10^{15}) - (1.2 \times 10^{15}))}{2} + \sqrt{\left(\frac{((2 \times 10^{15}) - (1.2 \times 10^{15}))}{2}\right)^2 + (1.5 \times 10^{10})^2} \end{aligned}$$

$$n_0 = 8 \times 10^{14} / \text{cm}^3$$

$$n_i^2 = n_0 p_0$$

$$p_0 = \frac{n_i^2}{n_0} = \frac{(1.5 \times 10^{10})^2}{8 \times 10^{14}}$$

$$p_0 = 2.81 \times 10^5 / \text{cm}$$

$$c.) \quad p_0 \approx (N_{af} + N_a) - N_d$$

$$4 \times 10^{15} \approx (N_{af} + 1.2 \times 10^{15})$$

$$N_{af} = 4.8 \times 10^{15} / \text{cm}^3 \quad \text{← Number of Boron atoms to be added}$$

$$n_i^2 = n_0 p_0$$

$$n_0 = \frac{n_i^2}{p_0} = \frac{(1.5 \times 10^{10})^2}{4 \times 10^{15}}$$

$$n_s = 5.62 \times 10^{14} / \text{cm}^3$$

- 4.54 Silicon at $T = 300$ K contains acceptor atoms at a concentration of $N_a = 5 \times 10^{15} \text{ cm}^{-3}$. Donor atoms are added forming an n-type compensated semiconductor such that the Fermi level is 0.215 eV below the conduction-band edge. What concentration of donor atoms are added?

$$n_s = N_c \exp \left[-\frac{(E_c - E_F)}{kT} \right] = (2.8 \times 10^{19}) \exp \left[\frac{-0.215}{0.0259} \right]$$

$$n_s = 6.95 \times 10^{15} / \text{cm}^3$$

$$n_s = N_d - N_a$$

$$6.95 \times 10^{15} = N_d - 5 \times 10^{15}$$

$$N_d = 1.2 \times 10^{16} / \text{cm}^3$$